Analog Power AM3826N

N-Channel 20-V (D-S) MOSFET With Schottky Diode

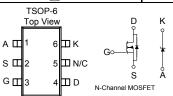
These miniature surface mount MOSFETs utilize a high cell density trench process to provide low $r_{DS(on)}$ and to ensure minimal power loss and heat dissipation. Typical applications are DC-DC converters and power management in portable and battery-powered products such as computers, printers, PCMCIA cards, cellular and cordless telephones.

•	Low $r_{DS(\mbox{\scriptsize on})}$ provides higher efficiency and
	extends battery life

- Low thermal impedance copper leadframe TSOP-6 saves board space
- Fast switching speed
- High performance trench technology

MOSFET PRODUCT SUMMARY					
$V_{DS}(V)$ $r_{DS(on)}(OHM)$ $I_{D}(A)$					
20	$0.047 @V_{CS} = -4.5V$	±4.1			
20	$0.055 @V_{CS} = -2.5V$	±3.8			

SCHOTTKYPRODUCTSUMMARY					
V _{KA} (V)	$V_{f}(V)$ Diode Forward Voltage	I _F (A)			
20	0.48V@1.0A	1.0			



Thigh performance trench technology								
ABSOLUTE MAXIMUM RATINGS (T _A = 25 °C UNLESS OTHERWISE NOTED)								
Parameter Parameter	Symbol	Maximum	Units					
Drain-Source Voltage (MOSFET)		V_{DS}	20					
Reverse Voltage (Schottky)		V_{KA}	20	V				
Cate-Source Voltage (MOSFET)		V_{cs}	±8					
Continuous Drain Current (T ₁ =150°C) (MOSFET) ^a	T _A =25°C	I_{D}	±4.1	A				
Continuous Diani Curient (15–150 C) (IVIOSFE1)	T _A =70°C	ър	±3.3					
Pulsed Drain Current (MOSFET) ^b		I_{DM}	±8					
Continuous Source Current (MOSFET Diode Conduction)	ı	I_S	1.05					
Average Forward Current (Schottky)		I_{F}	0.5					
Pulsed Forward Current (Schottky)		I_{FM}	8					
Maximum Power Dissipation (MOSFET) ^a	T _A =25°C		1.15	W				
WaxiitumFowei Dissipation(WOSFE1)	T _A =70°C	P_{D}	0.7					
Maying was Down Discinction (Schottly) ^a	T _A =25°C	1 D	1.0	vv				
Maximum Power Dissipation (Schottky) ^a	T _A =70°C		0.6					
Operating Junction and Storage Temperature Range		T_{J}, T_{stg}	-55 to 150	$^{\circ}\!\mathrm{C}$				
1		39 Stg						

THERMAL RESISTANCE RATINGS									
Parameter	Symbol	Тур	Max						
Maniana Innation to Analyzada	t <= 10 sec	R_{thJA}	93	110	0C/W				
Maximum Junction-to-Ambient ^a	Steady State	IX _{th} JA	130	150	°C/W				

Notes

- a. Surface Mounted on 1" x 1" FR4 Board.
- b. Pulse width limited by maximum junction temperature

MOSFET SPECIFICATIONS (T _A = 25°C UNLESS OTHERWISE NOTED)								
Parameter	Sambol	Test Conditions	Limits			Unit		
Falalletei	Symbol	rest conditions	Min	Тур	Max	OHIL		
Static								
Gate-Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{CS}$, $I_{D} = 250 \text{ uA}$	0.4					
Gate-Body Leakage	I _{GSS}	$V_{DS} = 0 V, V_{GS} = +/-8 V$			±100	nΑ		
Zero Gate Voltage Drain Ourrent	I _{DSS}	$V_{DS} = 16 \text{ V}, V_{GS} = 0 \text{ V}$			1	uΑ		
Zao Cate voltage Diam Curra it	DSS	$V_{DS} = 16 \text{ V}, V_{CS} = 0 \text{ V}, T_J = 55^{\circ}\text{C}$			10	un		
On-State Drain Current ^A	I _{D(on)}	$V_{DS} = 5 \text{ V}, V_{GS} = 4.5 \text{ V}$	5			Α		
Denies Courses On State DesigtanceA		$V_{CS} = 4.5 \text{ V}, I_D = 4.1 \text{ A}$	0.04		0.047	Ω		
Drain-Source On-State Resistance ^A	r _{DS(on)}	$V_{CS} = 2.5 \text{ V}, I_D = 3.8 \text{ A}$			0.055	12		
Forward Tranconductance ^A	9 _{fs}	$V_{DS} = 5 \text{ V}, I_D = 4.1 \text{ A}$		3		S		
Diode Forward Voltage	V_{SD}	$I_S = 1.05 \text{ A}, V_{CS} = 0 \text{ V}$		0.80		V		
Dynamic ^b								
Total Gate Charge	Q_g	$V_{DS} = 10 \text{ V}, V_{GS} = 4.5 \text{ V},$		7.5				
Gate-Source Charge	Q_{gs}	$v_{DS} = 10 \text{ v}, v_{GS} = 4.3 \text{ v},$ $I_{D} = 4.1 \text{ A}$		0.6		пС		
Gate-Drain Charge	Q _{gd}	I _D = 4. 1 A		1.0				
Turn-On Delay Time	t _{d(on)}			5				
Rise Time	t _r	$V_{DD} = 5 \text{ V}, R_L = 5 \text{ OHM},$		12				
Turn-Off Delay Time	t _{d(off)}	$V_{GEN} = 4.5 \text{ V}, R_G = 6 \text{ OHM}$		13		- ns		
Fall-Time	t _f			7				

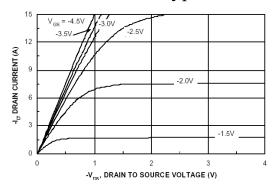
SCHOTTKY SPECIFICATIONS (T _A = 25°C UNLESS OTHERWISE NOTED)									
Parameter	Cymbal	Took Conditions	Limits			11:4			
Parameter	Symbol	Test Conditions	Min	Тур	Max	Unit			
Forward Voltage Drep	V	I _F = 0.5 A			0.48	V			
Forward Voltage Drop	V _F	$I_F = 0.5 \text{ A}, T_J = 125^{\circ}\text{C}$			0.4	V			
	I _m	V _r = 30 V			0.1				
Maximum Reverse Leakage Current		$V_r = 30 \text{ V}, T_J = 75^{\circ}\text{C}$			1	mΑ			
		$V_r = 30 \text{ V}, T_J = 125^{\circ}\text{C}$			10				
Junction Capacitance	C_T	V _r = 10 V		31		pF			

Notes

- a. Pulse test: $PW \le 300us duty cycle \le 2\%$.
- b. Guaranteed by design, not subject to production testing.

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Typical Electrical Characteristics



BAIN DORMALIZED

1.8

VGS=-2.0V

1.4

-2.5V

-3.5V

-4.5V

-4.5V

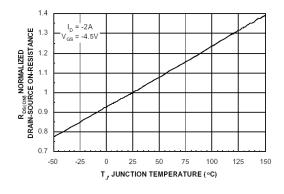
-4.5V

-4.5V

15.0, DRAIN CURRENT (A)

Figure 1. On-Region Characteristics

Figure 2. On-Resistance Variation with Drain Current and Gate Voltage



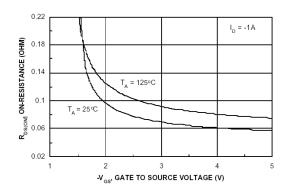
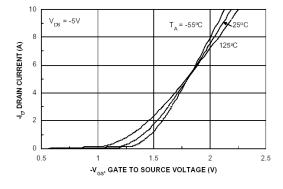


Figure 3. On-Resistance Variation with Temperature

Figure 4. On-Resistance Variation with Gate to Source Voltage



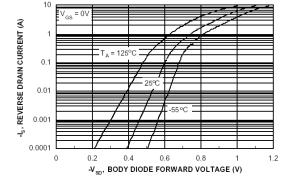
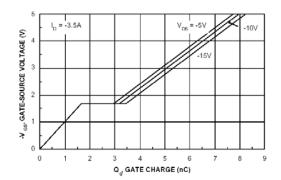


Figure 5. Transfer Characteristics

Figure 6. Body Diode Forward Voltage Variation with Source Current and Temperature

Typical Electrical Characteristics



1000 C_{ISS} C_{ISS}

Figure 7. Gate Charge Characteristic

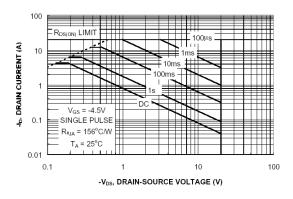


Figure 8. Capacitance Characteristic

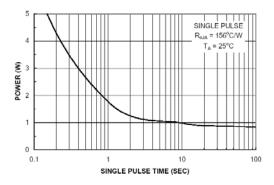


Figure 9. Maximum Safe Operating Area

Figure 10. Single Pulse Maximum Power
Dissipation



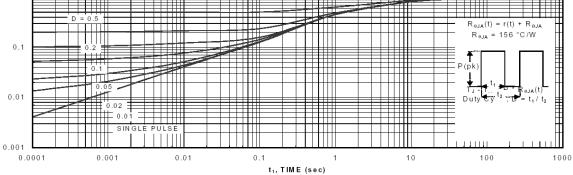
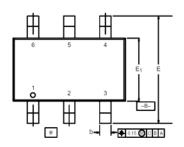
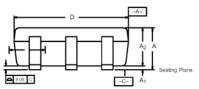


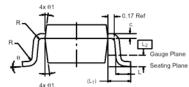
Figure 11. Transient Thermal Response Curve.

Package Information

TSOP-6: 6LEAD







	MILLIMETERS			ı	NCHES	;	
Dim	Min	Nom	Max	Min	Nom	Max	
Α	0.91	-	1.10	0.036	-	0.043	
A ₁	0.01	_	0.10	0.0004	_	0.004	
A ₂	0.84	_	1.00	0.033	0.038	0.039	
b	0.30	0.32	0.45	0.012	0.013	0.018	
С	0.10	0.15	0.20	0.004	0.006	0.008	
D	2.95	3.05	3.10	0.116	0.120	0.122	
E	2.70	2.85	2.98	0.106	0.112	0.117	
E ₁	1.55	1.65	1.70	0.061	0.065	0.067	
е	1.00 BSC			(0.0394 BSC	;	
L	0.35	_	0.50	0.014	_	0.020	
L ₁	0.60 Ref				0.024 Ref		
L ₂		0.25 BSC		0.010 BSC			
R	0.10	_	-	0.004	_	_	
θ	0°	4°	8°	0°	4°	8°	
θ_1		7° Nom	7° Nom 7° Nom				